M2716/M2716M 16K (2K x 8) UV ERASABLE PROM

Military

- Military Temperature Range M2716M: -55°C to +125°C (T_C) M2716: -55°C to +100°C (T_C)
- 5V ± 10% V_{CC}
- Pin Compatible to Intel's M2732A 32K FPROM
- Fast Access Time: 450 ns Maximum

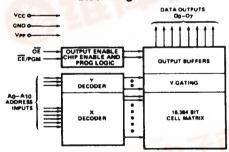
- Static Standby Mode
- Low Power Dissipation of 165 mW Maximum Standby Power
- Inputs and Outputs TTL Compatible
 During Read and Program
- Not Recommended for New Designs

The Intel M2716M and M2716 are 16,384-bit ultraviolet erasable and electrically programmable read only memories (EPROMs) specified over the military extended temperature range respectively. They operate from a single +5V power supply, have a static power-down mode, and feature fast, single-address location programming. It makes designing with EPROMs faster, easier and more economical. Both products are manufactured from the same dice. Except for the operating temperature range, both products have the same electrical and programming specifictions.

The M2716/M2716M has a static standby mode which reduces the power dissipation without increasing access time. The active power dissipation is reduced by over 60% in the standby power mode. Both are pin compatible to Intel's 32K military EPROM, the M2732A.

The M2716/M2716M has the simplest and fastest method devised yet for programming EPROMs—single pulse TTL level programming. No need for high voltage pulsing because all programming controls are handled by TTL signals. Program any location at any time—either individually, sequentially or at random, with the M2716's single-address location programming. Total programming time for all 16,384 bits is only 100 seconds.

Block Diagram



271006-3

Pin Configurations

| M2 | 716 | M2732A | | | | |
|--|--|--|--|--|--|--|
| A, C 1 A, C 2 A, C 3 A, C 4 A, C 5 A, C 6 | 24 DV cc 23 DA, 22 DA, 21 DV, 20 DOE 19 DA, | A, U 1 A, U 2 A, U 3 A, U 4 A, U 5 A, U 6 | 24 DV.c. 23 DA. 22 DA. 21 DA. 20 DŌE V | | | |
| A, C 7 A, C 8 O, C 10 O, C 11 GNDC 12 | 18 DCE 17 DO, 16 DO, 15 DO, 14 DO, 13 DO, | A.U. 7 A.U. 8 O.U. 9 O.U. 10 O.U. 11 GND C 12 | 18 DCE 17 DO, 16 DO, 15 DO, 14 DO, 13 DO, | | | |
| 3 100 | 271006-1 | | 271006-2 | | | |

Mode Selection

| | 10000 | 00100110 | •• | | |
|-----------------|-------------------|-----------------|-------------|-------------------------|--------------------------|
| Pins Mode | CE/PGM (18) | OE (20) | Vpp (21) | V _{CC} (24) | Outputs (9-11, 13-17) |
| Read | V _{IL} | VIL | + 5 | +5 | Dout |
| Standby | V _{IH} | Don't Care | + 5 | +5 | High Z |
| Program | Pulsed VIL to VIH | V _{IH} | + 25 | +5 | D _{IN} |
| Program Verify | V _I L | VIL | + 25 | +5 | D _{OUT} |
| Program Inhibit | V _{IL} | V _{IH} | + 25 | +5 | High Z |

Pin Names

| A | 0-A ₁₀ | Addresses | | | | |
|---|-------------------|---------------------|--|--|--|--|
| C | E/PGM | Chip Enable/Program | | | | |
| Ö | Ē | Output Enable | | | | |
| C | 0-07 | Outputs | | | | |
| L | 0-07 | Outputs | | | | |

December 1989 Order Number: 271006-003

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ABSOLUTE MAXIMUM RATINGS*

 NOTICE: This is a production data sheet. The specifications are subject to change without notice.

*WARNING: Stressing the device beyond the "Absolute Maximum Ratings" may cause permanent damage. These are stress ratings only. Operation beyond the "Operating Conditions" is not recommended and extended exposure beyond the "Operating Conditions" may affect device reliability.

D.C. AND A.C. OPERATING CONDITIONS

| | Case Temperature (Instant On) | V _{CC} | V _{PP} |
|--------|----------------------------------|-----------------|-----------------|
| M2716M | -55°C to +125°C | 5V ± 10% | Vcc |
| M2716 | -55°C to +100°C | 5V ± 10% | Vcc |

D.C. CHARACTERISTICS

| Cumbal | Parameter | Limits | | | 11-24- | | |
|---------------------------------|-----------------------------------|--------|--------|---------------------|--------|--|--|
| Symbol | rarameter | Min | Typ(3) | Max | Units | Comments | |
| ILI | Input Load Current | | | 10 | μΑ | V _{IN} = 5.5V | |
| I _{LO} | Output Leakage Current | | | 10 | μΑ | V _{OUT} = 5.5V | |
| I _{PP1} (2) | Vpp Current | | | 6 | mA | V _{PP} = 5.5V | |
| I _{CC1} ⁽²⁾ | V _{CC} Current (Standby) | | 10 | 30 | mA | $\overline{CE} = V_{IH}, \overline{OE} = V_{IL}$ | |
| I _{CC2} (2) | V _{CC} Current (Active) | | 57 | 115 | mA | OE = CE = VIL | |
| V _{IL} | Input Low Voltage | -0.1 | | 0.8 | V | | |
| V _{IH} | Input High Voltage | 2.0 | | V _{CC} + 1 | V. | | |
| VOL | Output Low Voltage | | | 0.45 | V | I _{OL} = 2.1 mA | |
| V _{OH} | Output High Voltage | 2.4 | | | V | $I_{OH} = -400 \mu A$ | |

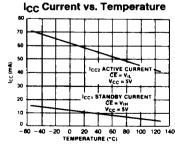
NOTES:

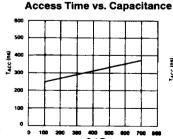
1. V_{CC} must be applied simultaneously or before V_{PP} and removed simultaneously or after V_{PP}.

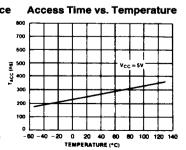
2. Vpp can be connected directly to V_{CC} except during programming. The supply current will then be the sum of I_{CC} and I_{PP1}

3. Typical values are for $T_C = 25^{\circ}C$ and nominal supply voltages.

TYPICAL CHARACTERISTICS







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intel

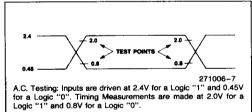
A.C. CHARACTERISTICS

| Symbol | B | | Limits | | Units | Comments |
|-----------------|---|-----|--------|-----|-------|--|
| | Parameter | Min | Typ(3) | Max | Units | |
| tACC | Address to Output Delay | | | 450 | ns | CE = OE = VIL |
| t _{CE} | CE to Output Delay | | | 450 | ns | OE = VIL |
| t _{OE} | Output Enable to Output Delay | | | 150 | ns | CE = V _{IL} |
| t _{DF} | Output Enable High to Output Float | 0 | | 130 | ns | CE = V _{IL} |
| tон | Output Hold from Addresses, CE or OE Whichever Occurred First | 0 | | | ns | $\overline{CE} = \overline{OE} = V_{IL}$ |

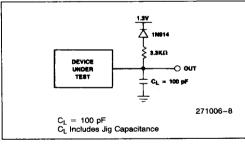
CAPACITANCE T_C = 25°C, f = 1 MHz

| Symbol | Parameter | Тур | Max | Units | Conditions |
|--------|--------------------|-----|-----|-------|-----------------------|
| CiN | Input Capacitance | 4 | 6 | рF | $V_{IN} = 0V$ |
| Cout | Output Capacitance | 8 | 12 | рF | V _{OUT} = 0V |

A.C. TESTING, OUTPUT WAVEFORM

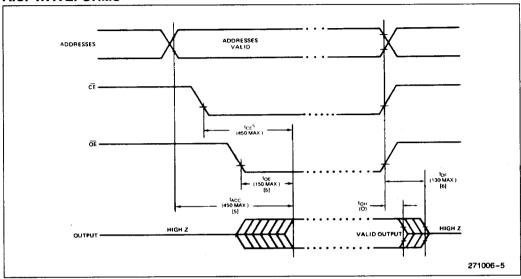


A.C. TESTING LOAD CIRCUIT



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A.C. WAVEFORMS(5)



NOTES:

- 1. VCC must be applied simultaneously or before VPP and removed simultaneously or after VPP.
- 2. Vpp can be connected directly to V_{CC} except during programming. The supply current will then be the sum of I_{CC} and I_{DD1}.
- Typical values are for T_C = 25°C and nominal supply voltages.
- 4. All times shown in paraentheses are minimum and are nsec unless otherwise specified.
- 5. OE may be delayed up to tACC-tOE after the falling edge of CE without impact on tACC.
- 6. Output Float is defined as the point where data is no longer driven.

DEVICE OPERATION

The five modes of operation of the M2716 are listed in Table 1. It should be noted that all inputs for the five modes are at TTL levels. The power supplies required are a $+5V\ V_{CC}$ and a Vpp. The Vpp power supply must be at 25V during the three programming modes, and must be at 5V in the other two modes.

Read Mode

The M2716 has two control functions, both of which must be logically satisfied in order to obtain data at the outputs. Chip Enable (\overline{CE}) is the power control and should be used for device selection. Output Enable (\overline{OE}) is the output control and should be used to gate data to the output pins, independent of de-

Mode Selection

| Pins Mode | CE/PGM (18) | ÖE (20) | V _{PP} (21) | V _{CC} (24) | Outputs (9-11, 13-17) | | | |
|-----------------|---|-----------------|----------------------|----------------------|--------------------------|--|--|--|
| Read | V _{IL} | V _{IL} | +5 | +5 | D _{OUT} | | | |
| Standby | V _{IH} | Don't Care | +5 | +5 | High Z | | | |
| Program | Pulsed V _{IL} to V _{IH} | V _{IH} | + 25 | +5 | D _{IN} | | | |
| Program Verify | V _{IL} | V _{IL} | + 25 | +5 | D _{OUT} | | | |
| Program Inhibit | V _{IL} | V _{IH} | + 25 | +5 | High Z | | | |



vice selection. Assuming that addresses are stable, address access time (t_{ACC}) is equal to the delay from \overline{CE} to output (t_{CE}). Data is available at the outputs 150 ns (t_{OE}) after the falling edge of \overline{OE} , assuming that \overline{CE} has been low and addresses have been stable for at least $t_{ACC}-t_{OE}$.

Standby Mode

The M2716 has a standby mode which reduces the active power dissipation by 75%, from 633 mW to 165 mW. The M2716 is placed in the standby mode by applying a TTL high special to the CE input. When in standby mode, the outputs are in a high impedance state, independent of the \overline{OE} input.

Output Or-Tieing

Because M2716's are usually used in larger memory arrays, Intel has provided a 2 line control function that accommodates this use of multiple memory connections. The two line control function allows for

- a) the lowest possible memory power dissipation, and,
- b) complete assurance that output bus contention will not occur.

To most efficiently use these two control lines, it is recommended that \overline{CE} (pin 18) be decoded and used as the primary device selecting function, while \overline{OE} (pin 20) be made a common connection to all devices in the array and connected to the READ line from the system control bus. This assures that all deselected memory devices are in their low power standby mode and that the output pins are only active when data is desired from a particular memory device.

Programming

Initially, and after each erasure, all bits of the M2716 are in the "1" state. Data is introduced by selectively programming "0's" into the desired bit locations. Although only "0's" will be programmed, both "1's" and "0's" can be presented in the data word. The only way to change a "0" to a "1" is by untraviolet light erasure.

The M2716 is in the programming mode when the V_{PP} power supply is at 25V and ŌE is at V_{IH}. The data to be programmed is applied 8 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL.

When the address and data are stable, a 50 ms, active high, TTL program pulse is applied to the CE input. A program pulse must be applied at each address location to be programmed. You can program any location at any time—either individually, sequentially or at random. The program pulse has a maximum width of 55 ms. The M2716 must not be programmed with a DC signal applied to the CE input.

Programming of multiple M2716's in parallel with the same data can be easily accomplished due to the simplicity of the programming requirements. Like inputs of the paralleled M2716's may be connected together when they are programmed with the same data. A high level TTL pulse applied to the $\overline{\text{CE}}$ input programs the paralleled M2716's.

Program Inhibit

Programming of multiple M2716's in parallel with different data is also easily accomplished. Except for \overline{CE} , all like units (including \overline{OE}) of the parallel M2716's may be common. A TTL level program pulse applied to a M2716's \overline{CE} input with V_{PP} at 25V will program that M2716. A low level \overline{CE} input inhibits the other M2716 from being programmed.

Program Verify

A verify should be performed on the programmed bits to determine that they were correctly programmed. The verify may be performed with V_{PP} at 25V. Except during programming and program verify. V_{PP} must be at 5V.

DEVICE RELIABILITY

The M2716 is built on a proven 2 layer polysilicon NMOS technology. Extensive testing and monitoring has allowed us to achieve failure rates equal to other memory devices.







PROGRAMMING CHARACTERISTICS

D.C. PROGRAMMING CHARACTERISTICS

 $T_C = 25^{\circ}C \pm 5^{\circ}C, V_{CC}^{(1)} = 5V \pm 5\%, V_{PP}^{(1,2)} = 25V \pm 1V$

| Symbol | Parameter | Min | Тур | Max | Units | Comments |
|------------------|--|------|-----|---------------------|-------|--------------------------------------|
| I _{LI} | Input Current (for Any Input) | | | 10 | μΑ | $V_{IN} = 5.25 V \text{ or } 0.45 V$ |
| I _{PP1} | V _{PP} Supply Current | | | 5 | mA | CE = V _{IL} |
| I _{PP2} | V _{PP} Supply Current During Programming Pulse | | | 30 | mA | CE = VIH |
| lcc | V _{CC} Supply Current | | | 100 | mA | |
| VIL | Input Low Level | -0.1 | | 0.8 | ٧ | |
| V _{1H} | Input High Level | 2.0 | | V _{CC} + 1 | V | |

A.C. PROGRAMMING CHARACTERISTICS

 $T_C = 25^{\circ}C \pm 5^{\circ}C$, $V_{CC}^{(1)} = 5V \pm 5\%$, $V_{PP}^{(1,2)} = 25V \pm 1V$

| Symbol | Parameter | Min | Тур | Max | Units | Comments |
|------------------|-------------------------------------|-----|-----|-----|-------|----------|
| t _{AS} | Address Setup Time | 2 | | | μs | |
| toes | OE Setup Time | 2 | | | μs | |
| t _{DS} | ▼Data Setup Time | 2 | | | μs | |
| t _{AH} | Address Hold Time | 2 | | | μs | |
| ^t OEH | OE Hold Time | 2 | | | μs | 1 |
| t _{DH} | Data Hold Time | 2 | | | μs | |
| t _{DFP} | Output Enable to Output Float Delay | 0 | | 200 | ns | CE = VIL |
| ^t OE | Output Enable to Output Delay | | | 200 | ns | ČĒ = VIL |
| t _{PW} | Program Pulse Width | 45 | 50 | 55 | ms | |
| t _{PRT} | Program Pulse Rise Time | 5 | | | ns | |
| tpFT | Program Pulse Fall Time | 5 | | | ns | |

A.C. CONDITIONS OF TEST

| Input Rise and Fall Times (10% to 90%) | 20 ns |
|--|-------------|
| Input Pulse Levels | 0.8 to 2.2V |
| Input Timing Reference Level | 0.8V and 2V |
| Output Timing Reference Level | 0.8V and 2V |

NOTES:

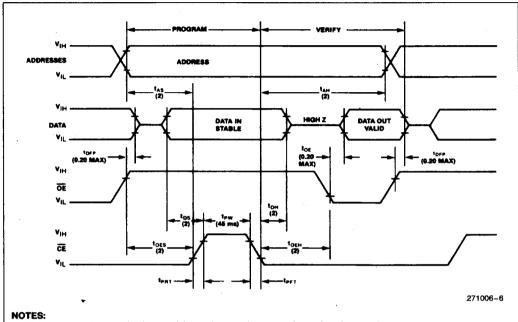
1. V_{CC} must be applied simultaneously or before V_{PP} and removed simultaneously or after V_{PP}. The M2716 must not be inserted into or removed from a board with V_{PP} at 25 ± 1V to prevent damage to the device.

 The maximum allowable voltage which may be applied to the V_{PP} pin during programming is +26V. Care must be taken when switching the V_{PP} supply to prevent overshoot exceeding this 26V maximum specification.





PROGRAMMING WAVEFORMS



- All times shown in parenthesis are minimum times and are μs unless otherwise noted.
 t_{OE} and t_{DFP} are characteristics of the device but must be accommodated by the programmer.

